

Application No.	Applicant(s)	
10/086,764	METCALF ET AL.	
Examin r	Art Unit	
Kimberly D. Nguyen	2876	

CLASS SUBCLASS CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)	ORIGINAL					CRO	SS REFERENC	CE(S)	
INTERNATIONAL CLASSIFICATION	CLASS	CLASS SUBCLASS		SUBCLASS (ONE SUBCLASS PER BLOCK)					
G 0 6 F 17/00	235	375	235	380	381	382	383		
	INTERNATIO	NAL CLASSIFICATION							
MICHAEL C. LEE	G 0 6	f 17/00							
MICHAEL C. LEE		1							
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MICHAEL C. LEE		1							
MICHAEL GLEE		/							
Kimberly D. Nguyen 4/22/04 SUPERVISORY PATENT EXAMINER	Kimberly D. Nguyen 4/22/04 (Assistant Examiner) (Date) William Struments (Date)			MICHAEL G. LEE SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 3/5/04			Total Claims Allowed: 23		
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Final Original Original Final Final Final Final Final Final	Original	Final	Original
1 31 4 61 91 121	151	16	181
2 32 5 62 92 122	152	17	182
3 33 6 63 93 123	153	18	183
4 34 7 64 94 124	154	19	184
5 35 8 65 95 125	155	:	185
6 36 9 66 96 126	156	20	186
7 37 67 97 127	157	21	187 10
8 38 68 98 128	158	22	188
9 39 69 99 129	159	23	189
10 40 70 100 130	160	:	190
11 41 71 101 131	161	:[191
12 42 72 102 132	162	:[192
13 43 73 103 133	163	:	193
14 44 74 104 134	164	:	194_
15 45 75 105 135	165	:[195
16 46 76 106 136	166	:	196
17 47 77 107 137	167	:	197
18 48 78 108 138	168	:	198
19 49 79 109 139	169		199
20 50 80 110 140	170	:[200
21 51 81 111 141	171	:	201
22 52 82 112 142	172	:L	202
23 53 83 113 143	173	:	203
24 54 84 114 144	174	:	204
25 55 85 115 145	175		205
26 56 86 116 146 11	176		206
27 57 87 117 12	177	:	207
28 1 58 88 118 148 13	178		208
29 2 59 89 119 149 14	179	:	209
30 3 60 90 120 150 15	180	:	210